# The role of annealing temperature on the optical energy gap and Urbach energy of Se:2%Sb thin films

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## Abstract:

The optical energy  $gap(E_{opt})$  and the width of the tails of localized states in the band gap ( $\Delta E$ ) for Se:2%Sb thin films prepared by thermal co-evaporation method as a function of annealing temperature are studied in the photon energy range (1 to 5.4)eV.Se2%Sb film was found to be indirect transition with energy gap of (1.973,2.077, 2.096, 2.17) eV at annealing temperature (295,370,445,520)K respectively.

The  $E_{opt}$  and  $\Delta E$  of Se:2%Sb films as a function of annealing temperature showed an increase in  $E_{opt}$  and a decrease in  $\Delta E$  with increasing the annealing temperature. This behavior may be related to structural defects and dangling bonds.

## **Introduction:**

Optical properties of thin films depend mainly on their volume and surface structures[1-2].Film structure is affected by its thickness, conditions of preparation, films material, substrate bulk material and its treatment after preparation [3-5].In recent years, the optical memory effects in amorphous semiconducting films have been investigated and utilized for various device applications[6].

The optical absorption coefficient for many amorphous and glassy materials is found to obey the relation:

 $\alpha h \upsilon = \beta (h \upsilon - Eopt)^r$  .....(1) where  $\upsilon$  is the frequency of the incident radiation,  $\beta$  is a constant which depends on density of state of conduction and valence bands, r is a constant depend on the nature of the transition and Eopt is the optical energy gap.

The relation was first derived by Tauc and Colleagues[1] who assumed that the electron density of states at band edges in regions of localized states is a parabolic function of energy .Davis and Mott[7] obtained the same relation. The width of the tails of localized states at the band edges can be estimated using the Urbach relation[8]:

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\alpha = \alpha_0 \exp(h\nu/\Delta E) \dots(2)
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where  $\alpha_0$  is a constant and  $\Delta E$  is a measure of the extent of the band tailing in the band gap of the material and determined from the reciprocal of the slope of ln $\alpha$  against photon energy.

This report will give results of a systematic study of the optical properties of Se:2%Sb amorphous thin films at different annealing temperature (295,370,445&520)K.

## **Experiment:**

The purity of the materials are (99.999% pure), were prepared at room temperature by thermal co-evaporation technique from two molybdenum boats in a vacuum at a pressure of  $about(5x10^{-6})$ Torr using Edwards 306 coating unit.The thickness of films was (~300±5)nm measured using Tolonsky methods.

The glassy nature of the samples were investigated using X-Ray diffraction. Spectral characteristics in the wavelength rang (200-1100)nm were measured using UV-visible recording spectrophotometer(UV-160 Schematize). The absorption coefficient( $\alpha$ ) calculated from the relation [9]:

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 $\alpha = 2.303 (A/t) \dots (3)$ 

where A is the absorbance and t is the thickness of the films. The optical band gap calculated from the intercept of  $(\alpha h \upsilon)^{1/2}$  data plotted as function of photon energy.

### **Results and discussions:**

The films samples unannealed and annealed at various temperature were amorphous which are conformed by X-ray diffraction as shown in fig. (1). Fig.(2) shows the plots of absorption coefficient ( $\alpha$ ) versus photon energy (hv) at different annealing temperature. As evident from Fig.(2),  $\alpha$  varies exponentially with hv in the measured range of  $\alpha$ . The absorption edge at room temperature is in a good agreement with the result on Se:2%Sb glass reported by Al-Ani et.al.[10,11].Fig.(3) show plots (αhυ)<sup>1/2</sup>against photon energy of Se:2%Sb films deposit at room temperature and annealed to (370,445,520)K. Fig.(4) shows the plot of  $\ln \alpha$  against photon energy of Se:2%Sb films deposited at room temperature. The reciprocal of the slope of curve give the value of corresponding  $\Delta E$ (0.45, 0.38, 0.29, 0.23) eV at annealing (295,370,445.520)K temperature respectively The extrapolated value of the indirect energy gap were (1.973,2.077,2.096,2.17)eV at annealing of (295,370,445,520)K temperature respectively as shown in Fig.(5) which is shows the variation of  $E_{opt}$  and  $\Delta E$  with T. The value of energy gap at room temperature is in agreement with Nang et.al.[12] but it's disagree with Choudhuri et. al.[13] which they found that the optical energy gap decrease with heat treatment.

The increasing in annealing temperature changes the density of localized state to a lower values as well as the localized state near the edges. Band gap at high temperature may be related to a decrease the structure defects such as dangling bonds, voids and decrease the disorder of the atomic bonds. The band tailing is a function of structural defects, therefor it decrease with increasing the annealing temperature as shown in Fig.(5).

## **Conclusion:**

The optical transmission of Se:2%Sb films with thicknesses of 300 nm have been measured in order to drive data on the absorption edge and band tailing . They found to be a indirect energy gap. The  $E_{opt}$  for Se:2%Sb films showed an increase from a value of 1.978eV at room temperature to 2.17eV at 520K. While  $\Delta E$  showed to be decreases with increasing the annealing temperature. These results may be related to a decrease in voids and dangling bonds.











### **References:**

 Saad, M.M., A.A.Saad, A.M.Elhelou, S.M.Botors, 1988, Optical properties of selenium thin films, Optica Applicata. 17(2):.105.

- 2. Al-Ani, S.K.,M.N.Makadsi, N.K. Abass.,2005,"Structural studies of the Ge-Se-Bisystem"J.of Natural and Applied Sciences, 9(2):399.
- **3.** Abbas, L.K.,2003,The study of the effect of annealingtemperature onthe optical properties of Ge-Se semicond. ,J.ofCollege of Education, 12(2):372.
- **4.** Chadhi,S.,S.Biswas,1981, Amorphous to crystallian Transition of selenium thin films of different thickness, JNon- Cryst. Solid, 4(171) : 171.
- 5. Twaddeii, V.A., W.C.Lacourse., and J.D .Mackenzie, 1972, "Impurity effects on the structure and electrical properties of non-crystalline selenium" J.of Noncrystalline Solids, 8(10):p.189.
- Khan,Z.H.,M.Zulfeqaur,andM.Husain, 2002,Electricalconductivity and thermoelectric power of a-Se<sub>80-x</sub>In<sub>x</sub> and Se<sub>80-x</sub>Ge<sub>20</sub>In<sub>x</sub> thin films."Canda J. Phys.10.
- Davis, E., N.Mott,1979,Electronic process in Non-crystallian materials 2<sup>nd</sup> ed.,Claredon Press.Oxford.
- **8.** Ihm J.,1985,.Urbach tails and the structure of chalcogenide Glasses. 53(3):293.
- **9.** Jenkins, F.,H. White, 1957,. Fundamentals of optics.,3<sup>rd</sup> ed.,Mc Graws-Hill Book Company,New York.
- **10.** Al-Ani,S.KM.N. Makadsi,L.K. Abbas, 1999, The effect of some additives on optical properties of a-Se thin films,Second Scientific Conference/ College of Scince/University of Baghdad.
- 11. Al-Ani,S.K.J., 1984, Studiesof Optical and related Properties of Thin Amorphuos film. Ph.D.Thesis, Brunel University, England.
- **12.** Nang,T.T.,M. OkudaM.,1979, Cmpositionnn dependenc of the rrefractive index and its photon energy variation in the system e-Se andAs-Se,J.of Non Cryst. Solid,33 (311):311-322.

**13.** Chaudhuri ,S.,S. Biswas, 1983, Variation of optical ofamorphous selenium film on heat treatment, J.Non-Cryst.Solids, 54:179-182.

# تأثير درجة حرارة التلدين على فجوة الطاقة البصرية وطاقة اورباخ لأغشية Se:2%Sb

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#### الخلاصة:

تم دراسة فجوة الطاقة البصرية وعرض الذيول للمستويات الموضعية لأغشية Se:2%Sb المحضرة بطريقة التبخير الحراري المزدوج كدالة لدرجة حرارة التلدين ضمن مدى طاقة الفوتون (1-5.4 ) ev.

لقدوجد ان لاغشية Se:2%Sb فجوة للطاقة غير مباشرة وبقيم eV (2.17,2.096,2.077,1.973) عند درجات التلدين (Eopt ) للغشية Se:2%Sb على التوالي ان فجوة الطاقة البصرية وعرض الذيول للمستويات الموضعية (Eopt ) و(ΔE) لاغشية Se:2%Sb كدالة لدرجة حرارة التلدين اظهر زيادة في فجوة الطاقة البصرية وعرض الذيول للمستويات الموضعية (ΔE) الذيول مع درجة الحرارة . هذا السلوك قد يعود الى عيوب التركيب والاواصر المتدلية.